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Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of Embedded - Microprocessors

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details	
Product Status	Active
Core Processor	ARM® Cortex®-A9
Number of Cores/Bus Width	2 Core, 32-Bit
Speed	852MHz
Co-Processors/DSP	Multimedia; NEON™ SIMD
RAM Controllers	LPDDR2, LVDDR3, DDR3
Graphics Acceleration	Yes
Display & Interface Controllers	Keypad, LCD
Ethernet	10/100/1000Mbps (1)
SATA	SATA 3Gbps (1)
USB	USB 2.0 + PHY (4)
Voltage - I/O	1.8V, 2.5V, 2.8V, 3.3V
Operating Temperature	-40°C ~ 125°C (TJ)
Security Features	ARM TZ, Boot Security, Cryptography, RTIC, Secure Fusebox, Secure JTAG, Secure Memory, Secure RTC, Tamper Detection
Package / Case	624-FBGA, FCBGA
Supplier Device Package	624-FCBGA (21x21)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mcimx6d6avt08ac

4.2 Power Supplies Requirements and Restrictions

The system design must comply with power-up sequence, power-down sequence, and steady state guidelines as described in this section to ensure the reliable operation of the device. Any deviation from these sequences may result in the following situations:

- Excessive current during power-up phase
- Prevention of the device from booting
- Irreversible damage to the processor

4.2.1 Power-Up Sequence

For power-up sequence, the restrictions are as follows:

- VDD_SNVS_IN supply must be turned ON before any other power supply. It may be connected (shorted) with VDD_HIGH_IN supply.
- If a coin cell is used to power VDD_SNVS_IN, then ensure that it is connected before any other supply is switched on.
- If the external SRC_POR_B signal is used to control the processor POR, then SRC_POR_B must be immediately asserted at power-up and remain asserted until the VDD_ARM_CAP, VDD_SOC_CAP, and VDD_PU_CAP supplies are stable. VDD_ARM_IN and VDD_SOC_IN may be applied in either order with no restrictions. In the absence of an external reset feeding the SRC_POR_B input, the internal POR module takes control. See the i.MX 6Dual/6Quad reference manual (IMX6DQRM) for further details and to ensure that all necessary requirements are being met.
- If the external SRC_POR_B signal is not used (always held high or left unconnected), the processor defaults to the internal POR function (where the PMU controls generation of the POR based on the power supplies). If the internal POR function is used, the following power supply requirements must be met:
  - VDD_ARM_IN and VDD_SOC_IN may be supplied from the same source, or
  - VDD_SOC_IN can be supplied before VDD_ARM_IN with a maximum delay of 1 ms.

NOTE

Ensure that there is no back voltage (leakage) from any supply on the board towards the 3.3 V supply (for example, from the external components that use both the 1.8 V and 3.3 V supplies).

NOTE

USB_OTG_VBUS and USB_H1_VBUS are not part of the power supply sequence and can be powered at any time.

4.2.2 Power-Down Sequence

No special restrictions for i.MX 6Dual/6Quad SoC.

4.6.2 General Purpose I/O (GPIO) DC Parameters

Table 22 shows DC parameters for GPIO pads. The parameters in Table 22 are guaranteed per the operating ranges in Table 6, unless otherwise noted.

Table 22. GPIO I/O DC Parameters

Parameter	Symbol	Test Conditions	Min	Max	Unit
High-level output voltage[1]	Voh	Ioh = -0.1 mA (DSE[2] = 001, 010) Ioh = -1 mA (DSE = 011, 100, 101, 110, 111)	OVDD – 0.15	—	V
Low-level output voltage[1]	Vol	Iol = 0.1 mA (DSE[2] = 001, 010) Iol = 1mA (DSE = 011, 100, 101, 110, 111)	—	0.15	V
High-Level DC input voltage[1, 3]	Vih	—	0.7 × OVDD	OVDD	V
Low-Level DC input voltage[1, 3]	Vil	—	0	0.3 × OVDD	V
Input Hysteresis	Vhys	OVDD = 1.8 V OVDD = 3.3 V	0.25	—	V
Schmitt trigger VT+[3, 4]	VT+	—	0.5 × OVDD	—	V
Schmitt trigger VT–[3, 4]	VT–	—	—	0.5 × OVDD	V
Input current (no pull-up/down)	Iin	Vin = OVDD or 0	-1	1	µA
Input current (22 kΩ pull-up)	Iin	Vin = 0 V Vin = OVDD	—	212 1	µA
Input current (47 kΩ pull-up)	Iin	Vin = 0 V Vin = OVDD	—	100 1	µA
Input current (100 kΩ pull-up)	Iin	Vin = 0 V Vin= OVDD	—	48 1	µA
Input current (100 kΩ pull-down)	Iin	Vin = 0 V Vin = OVDD	—	1 48	µA
Keeper circuit resistance	Rkeep	Vin = 0.3 x OVDD Vin = 0.7 x OVDD	105	175	kΩ

1 Overshoot and undershoot conditions (transitions above OVDD and below GND) on switching pads must be held below 0.6 V, and the duration of the overshoot/undershoot must not exceed 10% of the system clock cycle. Overshoot/ undershoot must be controlled through printed circuit board layout, transmission line impedance matching, signal line termination, or other methods. Non-compliance to this specification may affect device reliability or cause permanent damage to the device.

2 DSE is the Drive Strength Field setting in the associated IOMUX control register.

3 To maintain a valid level, the transition edge of the input must sustain a constant slew rate (monotonic) from the current DC level through to the target DC level, Vil or Vih. Monotonic input transition time is from 0.1 ns to 1 s.

4 Hysteresis of 250 mV is guaranteed over all operating conditions when hysteresis is enabled.

4.6.3 DDR I/O DC Parameters

The DDR I/O pads support LPDDR2 and DDR3/DDR3L operational modes.

4.9.3 External Interface Module (EIM)

The following subsections provide information on the EIM. Maximum operating frequency for EIM data transfer is 104 MHz. Timing parameters in this section that are given as a function of register settings or clock periods are valid for the entire range of allowed frequencies (0–104 MHz).

4.9.3.1 EIM Interface Pads Allocation

EIM supports 32-bit, 16-bit and 8-bit devices operating in address/data separate or multiplexed modes. Table 39 provides EIM interface pads allocation in different modes.

Table 39. EIM Internal Module Multiplexing[1]

Setup	Non Multiplexed Address/Data Mode							Multiplexed Address/Data mode	
	8 Bit				16 Bit		32 Bit	16 Bit	32 Bit
	MUM = 0, DSZ = 100	MUM = 0, DSZ = 101	MUM = 0, DSZ = 110	MUM = 0, DSZ = 111	MUM = 0, DSZ = 001	MUM = 0, DSZ = 010	MUM = 0, DSZ = 011	MUM = 1, DSZ = 001	MUM = 1, DSZ = 011
EIM_ADDR [15:00]	EIM_AD [15:00]	EIM_AD [15:00]	EIM_AD [15:00]	EIM_AD [15:00]	EIM_AD [15:00]	EIM_AD [15:00]	EIM_AD [15:00]	EIM_AD [15:00]	EIM_AD [15:00]
EIM_ADDR [25:16]	EIM_ADDR [25:16]	EIM_ADDR [25:16]	EIM_ADDR [25:16]	EIM_ADDR [25:16]	EIM_ADDR [25:16]	EIM_ADDR [25:16]	EIM_ADDR [25:16]	EIM_ADDR [25:16]	EIM_DATA [09:00]
EIM_DATA [07:00], EIM_EB0_B	EIM_DATA [07:00]	—	—	—	EIM_DATA [07:00]	—	EIM_DATA [07:00]	EIM_AD [07:00]	EIM_AD [07:00]
EIM_DATA [15:08], EIM_EB1_B	—	EIM_DATA [15:08]	—	—	EIM_DATA [15:08]	—	EIM_DATA [15:08]	EIM_AD [15:08]	EIM_AD [15:08]
EIM_DATA [23:16], EIM_EB2_B	—	—	EIM_DATA [23:16]	—	—	EIM_DATA [23:16]	EIM_DATA [23:16]	—	EIM_DATA [07:00]
EIM_DATA [31:24], EIM_EB3_B	—	—	—	EIM_DATA [31:24]	—	EIM_DATA [31:24]	EIM_DATA [31:24]	—	EIM_DATA [15:08]

[1] For more information on configuration ports mentioned in this table, see the i.MX 6Dual/6Quad reference manual (IMX6DQRM).

4 Refer to JEDEC DDR3 SDRAM Standards for Data Setup (tDS), Hold (tDH) and Slew Rate Derating tables.

Figure 26 shows the DDR3/DDR3L read timing diagram. The timing parameters for this diagram appear in Table 44.

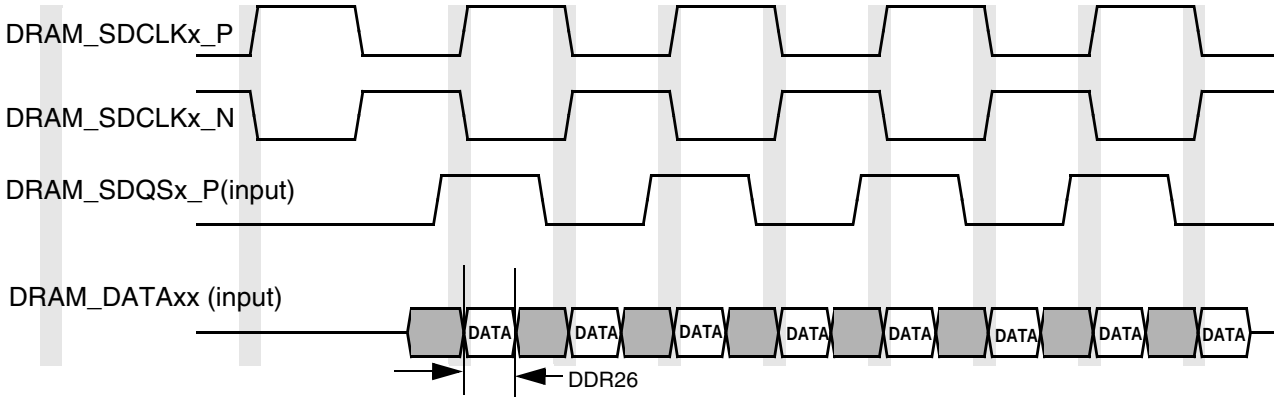

Figure 26. DDR3/DDR3L Read Cycle

4.9.4.2 LPDDR2 Parameters

Table 44. DDR3/DDR3L Read Cycle

ID	Parameter[1,2,3]	Symbol	CK = 532 MHz		Unit
			Min	Max	
DDR26	Minimum required DRAM_DATAxx valid window width.	—	450	—	ps

1 To receive the reported setup and hold values, the read calibration must be performed to locate the DRAM_SDQSx_P in the middle of DRAM_DATAxx window.

2 All measurements are in reference to Vref level.

3 Measurements were completed using balanced load and a 25 Ω resistor from outputs to DRAM_VREF.

Figure 27 shows the LPDDR2 basic timing diagram. The timing parameters for this diagram appear in Table 45.

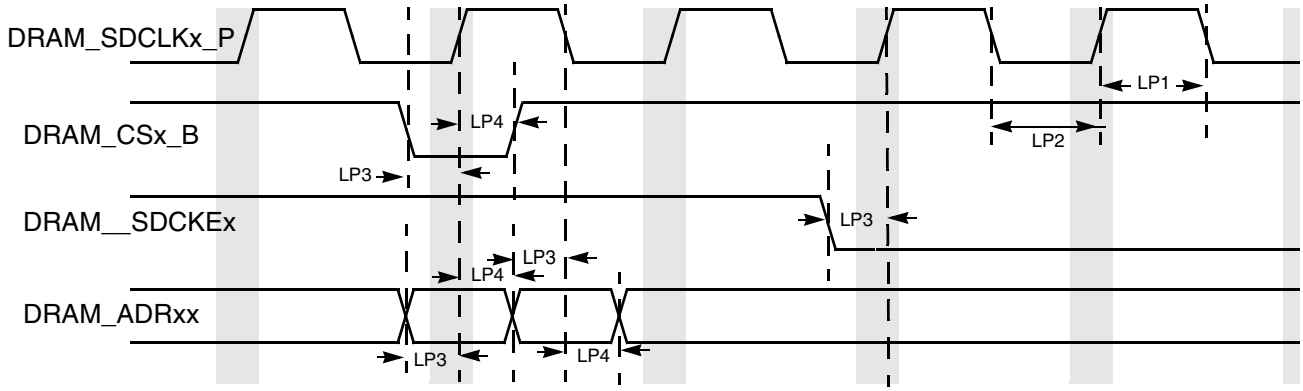

Figure 27. LPDDR2 Command and Address Timing Diagram

Table 48. Asynchronous Mode Timing Parameters[1] (continued)

ID	Parameter	Symbol	Timing T = GPMI Clock Cycle		Unit
			Min	Max	
NF16	Data setup on read	tDSR	—	(DS × T -0.67)/18.38 [see 5,6]	ns
NF17	Data hold on read	tDHR	0.82/11.83 [see 5,6]	—	ns

1 The GPMI asynchronous mode output timing can be controlled by the module's internal registers HW_GPMI_TIMING0_ADDRESS_SETUP, HW_GPMI_TIMING0_DATA_SETUP, and HW_GPMI_TIMING0_DATA_HOLD. This AC timing depends on these registers settings. In the table, AS/DS/DH represents each of these settings.

2 AS minimum value can be 0, while DS/DH minimum value is 1.

3 T = GPMI clock period -0.075ns (half of maximum p-p jitter).

4 NF12 is met automatically by the design.

5 Non-EDO mode.

6 EDO mode, GPMI clock ≈ 100 MHz (AS=DS=DH=1, GPMI_CTL1 [RDN_DELAY] = 8, GPMI_CTL1 [HALF_PERIOD] = 0).

In EDO mode (Figure 34), NF16/NF17 are different from the definition in non-EDO mode (Figure 33). They are called tREA/tRHOH (NAND_RE_B access time/NAND_RE_B HIGH to output hold). The typical value for them are 16 ns (max for tREA)/15 ns (min for tRHOH) at 50 MB/s EDO mode. In EDO mode, GPMI will sample NAND_DATAxx at rising edge of delayed NAND_RE_B provided by an internal DPLL. The delay value can be controlled by GPMI_CTRL1.RDN_DELAY (see the GPMI chapter of the i.MX 6Dual/6Quad reference manual (IMX6DQRM)). The typical value of this control register is 0x8 at 50 MT/s EDO mode. However, if the board delay is large enough and cannot be ignored, the delay value should be made larger to compensate the board delay.

Table 53. Enhanced Serial Audio Interface (ESAI) Timing (continued)

ID	Parameter[1,2]	Symbol	Expression[2]	Min	Max	Condition[3]	Unit
81	ESAI_TX_CLK rising edge to ESAI_TX_FS out (wr) low[5]	— —	— —	— —	22.0 12.0	x ck i ck	ns
82	ESAI_TX_CLK rising edge to ESAI_TX_FS out (wl) high	— —	— —	— —	19.0 9.0	x ck i ck	ns
83	ESAI_TX_CLK rising edge to ESAI_TX_FS out (wl) low	— —	— —	— —	20.0 10.0	x ck i ck	ns
84	ESAI_TX_CLK rising edge to data out enable from high impedance	— —	— —	— —	22.0 17.0	x ck i ck	ns
86	ESAI_TX_CLK rising edge to data out valid	— —	— —	— —	19.0 13.0	x ck i ck	ns
87	ESAI_TX_CLK rising edge to data out high impedance [6][7]	— —	— —	— —	21.0 16.0	x ck i ck	ns
89	ESAI_TX_FS input (bl, wr) setup time before ESAI_TX_CLK falling edge[5]	— —	— —	2.0 18.0	— —	x ck i ck	ns
90	ESAI_TX_FS input (wl) setup time before ESAI_TX_CLK falling edge	— —	— —	2.0 18.0	— —	x ck i ck	ns
91	ESAI_TX_FS input hold time after ESAI_TX_CLK falling edge	— —	— —	4.0 5.0	— —	x ck i ck	ns
95	ESAI_RX_HF_CLK/ESAI_TX_HF_CLK clock cycle	—	$2 \times T_C$	15	—	—	ns
96	ESAI_TX_HF_CLK input rising edge to ESAI_TX_CLK output	—	—	—	18.0	—	ns
97	ESAI_RX_HF_CLK input rising edge to ESAI_RX_CLK output	—	—	—	18.0	—	ns

1 i ck = internal clock
x ck = external clock
i ck a = internal clock, asynchronous mode
(asynchronous implies that ESAI_TX_CLK and ESAI_RX_CLK are two different clocks)
i ck s = internal clock, synchronous mode
(synchronous implies that ESAI_TX_CLK and ESAI_RX_CLK are the same clock)

2 bl = bit length
wl = word length
wr = word length relative

3 ESAI_TX_CLK(ESAI_TX_CLK pin) = transmit clock
ESAI_RX_CLK(ESAI_RX_CLK pin) = receive clock
ESAI_TX_FS(ESAI_TX_FS pin) = transmit frame sync
ESAI_RX_FS(ESAI_RX_FS pin) = receive frame sync
ESAI_TX_HF_CLK(ESAI_TX_HF_CLK pin) = transmit high frequency clock
ESAI_RX_HF_CLK(ESAI_RX_HF_CLK pin) = receive high frequency clock

4 For the internal clock, the external clock cycle is defined by Icyc and the ESAI control register.

5 The word-relative frame sync signal waveform relative to the clock operates in the same manner as the bit-length frame sync signal waveform, but it spreads from one serial clock before the first bit clock (like the bit length frame sync signal), until the second-to-last bit clock of the first word in the frame.

6 Periodically sampled and not 100% tested.

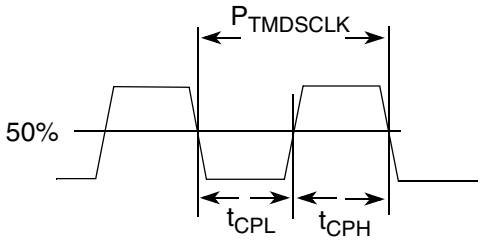

Figure 59. TMDS Clock Signal Definitions

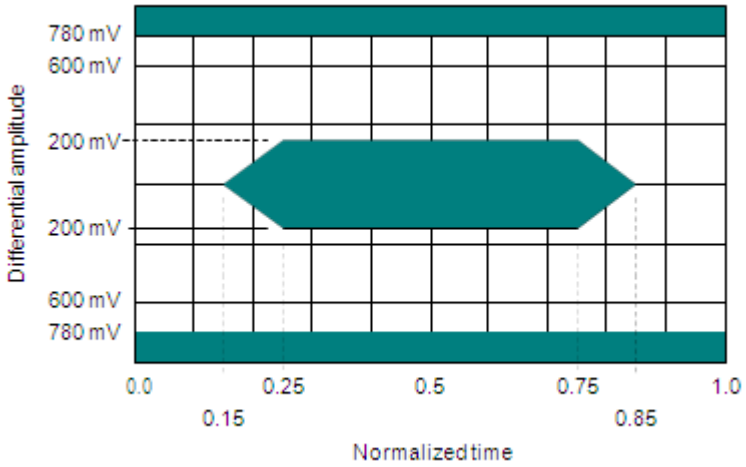

Figure 60. Eye Diagram Mask Definition for HDMI Driver Signal Specification at TP1

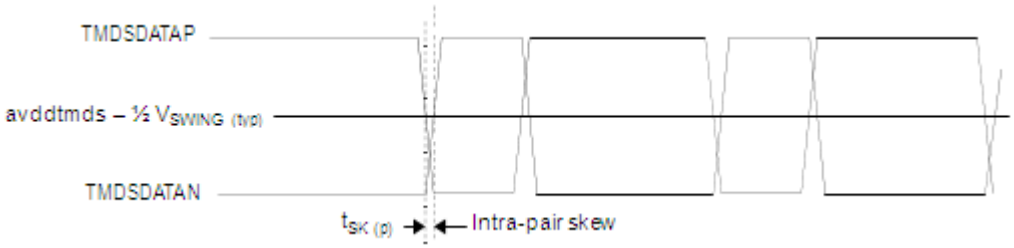

Figure 61. Intra-Pair Skew Definition

4.11.10.3 Electrical Characteristics

Figure 67 depicts the sensor interface timing. IPU2_CSIx_PIX_CLK signal described here is not generated by the IPU. Table 67 lists the sensor interface timing characteristics.

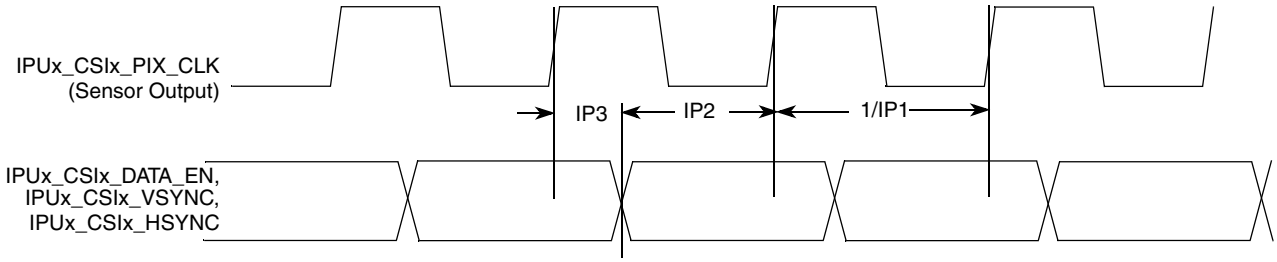

Figure 67. Sensor Interface Timing Diagram

Table 67. Sensor Interface Timing Characteristics

ID	Parameter	Symbol	Min	Max	Unit
IP1	Sensor output (pixel) clock frequency	Fpck	0.01	180	MHz
IP2	Data and control setup time	Tsu	2	—	ns
IP3	Data and control holdup time	Thd	1	—	ns

4.11.10.4 IPU Display Interface Signal Mapping

The IPU supports a number of display output video formats. Table 68 defines the mapping of the Display Interface Pins used during various supported video interface formats.

Table 68. Video Signal Cross-Reference

i.MX 6Dual/6Quad	LCD							Comment[1,2]
Port Name (x = 0, 1)	RGB, Signal Name (General)	RGB/TV Signal Allocation (Example)						
		16-bit RGB	18-bit RGB	24 Bit RGB	8-bit YCrCb[3]	16-bit YCrCb	20-bit YCrCb	
IPUx_DISPx_DAT00	DAT[0]	B[0]	B[0]	B[0]	Y/C[0]	C[0]	C[0]	—
IPUx_DISPx_DAT01	DAT[1]	B[1]	B[1]	B[1]	Y/C[1]	C[1]	C[1]	—
IPUx_DISPx_DAT02	DAT[2]	B[2]	B[2]	B[2]	Y/C[2]	C[2]	C[2]	—
IPUx_DISPx_DAT03	DAT[3]	B[3]	B[3]	B[3]	Y/C[3]	C[3]	C[3]	—
IPUx_DISPx_DAT04	DAT[4]	B[4]	B[4]	B[4]	Y/C[4]	C[4]	C[4]	—
IPUx_DISPx_DAT05	DAT[5]	G[0]	B[5]	B[5]	Y/C[5]	C[5]	C[5]	—
IPUx_DISPx_DAT06	DAT[6]	G[1]	G[0]	B[6]	Y/C[6]	C[6]	C[6]	—

Table 69. Synchronous Display Interface Timing Characteristics (Pixel Level) (continued)

ID	Parameter	Symbol	Value	Description	Unit
IP5o	Offset of IPP_DISP_CLK	Todicp	DISP_CLK_OFFSET × Tdiclk	DISP_CLK_OFFSET—offset of IPP_DISP_CLK edges from local start point, in DI_CLK×2 (0.5 DI_CLK Resolution). Defined by DISP_CLK counter.	ns
IP13o	Offset of VSYNC	Tovs	VSYNC_OFFSET × Tdiclk	VSYNC_OFFSET—offset of Vsync edges from a local start point, when a Vsync should be active, in DI_CLK×2 (0.5 DI_CLK Resolution). The VSYNC_OFFSET should be built by suitable DI's counter.	ns
IP8o	Offset of HSYNC	Tohs	HSYNC_OFFSET × Tdiclk	HSYNC_OFFSET—offset of Hsync edges from a local start point, when a Hsync should be active, in DI_CLK×2 (0.5 DI_CLK Resolution). The HSYNC_OFFSET should be built by suitable DI's counter.	ns
IP9o	Offset of DRDY	Todrdy	DRDY_OFFSET × Tdiclk	DRDY_OFFSET—offset of DRDY edges from a suitable local start point, when a corresponding data has been set on the bus, in DI_CLK×2 (0.5 DI_CLK Resolution). The DRDY_OFFSET should be built by suitable DI's counter.	ns

[1] Display interface clock period immediate value.

$$Tdicp = \begin{cases} T_{diclk} \times \frac{DISP\_CLK\_PERIOD}{DI\_CLK\_PERIOD}, & \text{for integer } \frac{DISP\_CLK\_PERIOD}{DI\_CLK\_PERIOD} \\ T_{diclk}\left(floor\left[\frac{DISP\_CLK\_PERIOD}{DI\_CLK\_PERIOD}\right] + 0.5 \pm 0.5\right), & \text{for fractional } \frac{DISP\_CLK\_PERIOD}{DI\_CLK\_PERIOD} \end{cases}$$

DISP_CLK_PERIOD—number of DI_CLK per one Tdicp. Resolution 1/16 of DI_CLK.
DI_CLK_PERIOD—relation of between programing clock frequency and current system clock frequency
Display interface clock period average value.

$$\bar{T}dicp = T_{diclk} \times \frac{DISP\_CLK\_PERIOD}{DI\_CLK\_PERIOD}$$

[2] DI's counter can define offset, period and UP/DOWN characteristic of output signal according to programed parameters of the counter. Same of parameters in the table are not defined by DI's registers directly (by name), but can be generated by corresponding DI's counter. The SCREEN_WIDTH is an input value for DI's HSYNC generation counter. The distance between HSYNCs is a SCREEN_WIDTH.

The maximum accuracy of UP/DOWN edge of controls is:

$$Accuracy = (0.5 \times T_{diclk}) \pm 0.62ns$$

Table 76. MediaLB 6-Pin Interface Electrical DC Specifications (continued)

Parameter	Symbol	Test Conditions	Min	Max	Unit
Common-mode output voltage: (V_{O+} - V_{O-}) / 2	V_{OCM}	—	1.0	1.5	V
Difference in common-mode output between (high/low) steady-states: I $V_{OCM, high}$ - $V_{OCM, low}$ I	ΔV_{OCM}	—	-50	50	mV
Variations on common-mode output during a logic state transitions	V_{CMV}	See Note[2]	—	150	mVpp
Short circuit current	$I I_{OS} I$	See Note[3]	—	43	mA
Differential output impedance	Z_O	—	1.6	—	kΩ
Receiver Characteristics					
Differential clock input: • logic low steady-state • logic high steady-state • hysteresis	 V_{ILC} V_{IHC} V_{HSC}	See Note[4]	 50 -25	 -50 25	 mV mV mV
Differential signal/data input: • logic low steady-state • logic high steady-state	 V_{ILS} V_{IHS}	—	 — 50	 -50 —	 mV mV
Signal-ended input voltage (steady-state): • MLB_SIG_P, MLB_DATA_P • MLB_SIG_N, MLB_DATA_N	 V_{IN+} V_{IN-}	—	 0.5 0.5	 2.0 2.0	 V V

1 The signal-ended output voltage of a driver is defined as V_{O+} on MLB_CLK_P, MLB_SIG_P, and MLB_DATA_P. The signal-ended output voltage of a driver is defined as V_{O-} on MLB_CLK_N, MLB_SIG_N, and MLB_DATA_N.

2 Variations in the common-mode voltage can occur between logic states (for example, during state transitions) as a result of differences in the transition rate of V_{O+} and V_{O-}.

3 Short circuit current is applicable when V_{O+} and V_{O-} are shorted together and/or shorted to ground.

4 The logic state of the receiver is undefined when -50 mV < V_{ID} < 50 mV.

4.11.15.1 PCIE_REXT Reference Resistor Connection

The impedance calibration process requires connection of reference resistor 200 Ω. 1% precision resistor on PCIE_REXT pads to ground. It is used for termination impedance calibration.

4.11.16 Pulse Width Modulator (PWM) Timing Parameters

This section describes the electrical information of the PWM. The PWM can be programmed to select one of three clock signals as its source frequency. The selected clock signal is passed through a prescaler before being input to the counter. The output is available at the pulse-width modulator output (PWMO) external pin.

Figure 89 depicts the timing of the PWM, and Table 80 lists the PWM timing parameters.

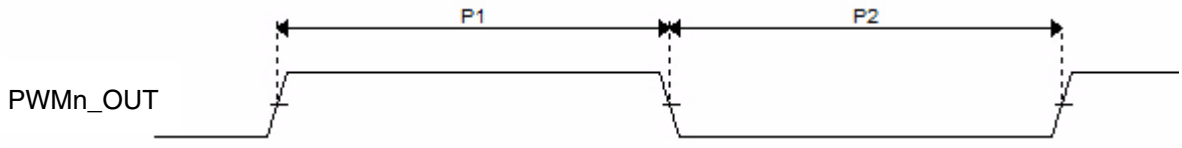

Figure 89. PWM Timing

Table 80. PWM Output Timing Parameters

ID	Parameter	Min	Max	Unit
—	PWM Module Clock Frequency	0	ipg_clk	MHz
P1	PWM output pulse width high	15	—	ns
P2	PWM output pulse width low	15	—	ns

4.11.17 SATA PHY Parameters

This section describes SATA PHY electrical specifications.

4.11.17.1 Transmitter and Receiver Characteristics

The SATA PHY meets or exceeds the electrical compliance requirements defined in the SATA specifications.

NOTE

The tables in the following sections indicate any exceptions to the SATA specification or aspects of the SATA PHY that exceed the standard, as well as provide information about parameters not defined in the standard.

The following subsections provide values obtained from a combination of simulations and silicon characterization.

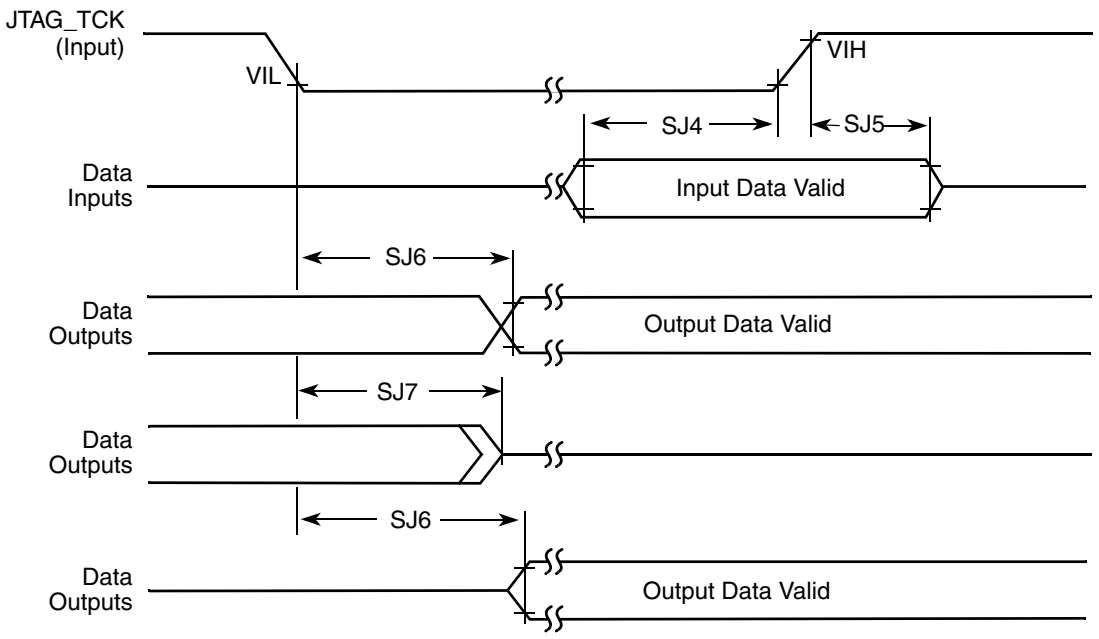

Figure 91. Boundary Scan (JTAG) Timing Diagram

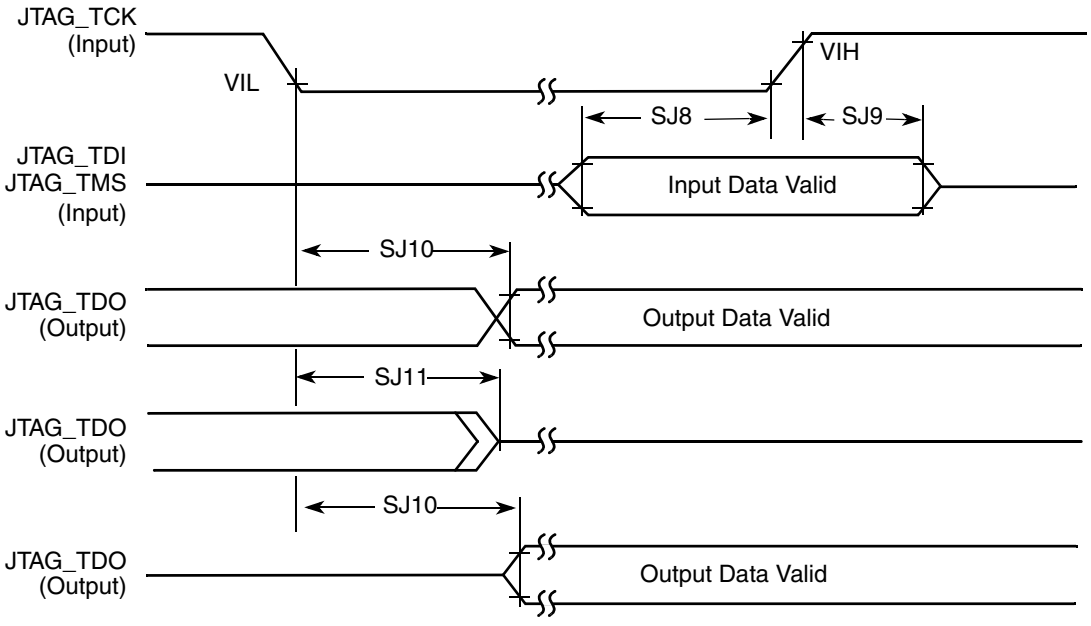

Figure 92. Test Access Port Timing Diagram

Table 84. SPDIF Timing Parameters

Parameter	Symbol	Timing Parameter Range		Unit
		Min	Max	
SPDIF_IN Skew: asynchronous inputs, no specs apply	—	—	0.7	ns
SPDIF_OUT output (Load = 50pf) • Skew • Transition rising • Transition falling	 — — —	 — — —	 1.5 24.2 31.3	ns
SPDIF_OUT output (Load = 30pf) • Skew • Transition rising • Transition falling	 — — —	 — — —	 1.5 13.6 18.0	ns
Modulating Rx clock (SPDIF_SR_CLK) period	srckp	40.0	—	ns
SPDIF_SR_CLK high period	srckph	16.0	—	ns
SPDIF_SR_CLK low period	srckpl	16.0	—	ns
Modulating Tx clock (SPDIF_ST_CLK) period	stclkp	40.0	—	ns
SPDIF_ST_CLK high period	stclkph	16.0	—	ns
SPDIF_ST_CLK low period	stclkpl	16.0	—	ns

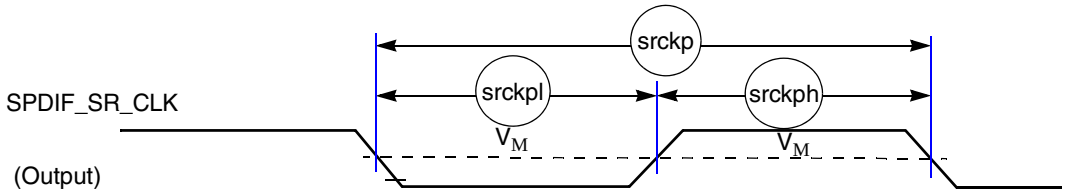

Figure 94. SPDIF_SR_CLK Timing Diagram

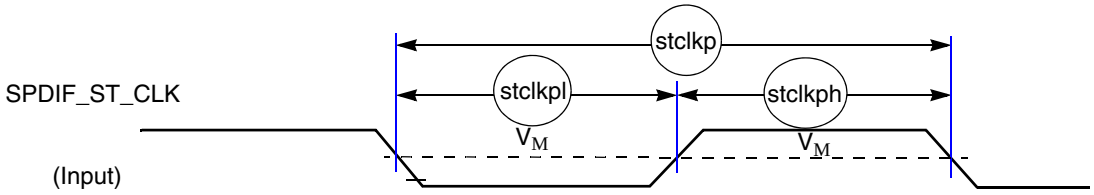

Figure 95. SPDIF_ST_CLK Timing Diagram

4.11.20 SSI Timing Parameters

This section describes the timing parameters of the SSI module. The connectivity of the serial synchronous interfaces are summarized in Table 85.

Table 85. AUDMUX Port Allocation

Port	Signal Nomenclature	Type and Access
AUDMUX port 1	SSI 1	Internal
AUDMUX port 2	SSI 2	Internal
AUDMUX port 3	AUD3	External – AUD3 I/O
AUDMUX port 4	AUD4	External – EIM or CSPI1 I/O through IOMUXC
AUDMUX port 5	AUD5	External – EIM or SD1 I/O through IOMUXC
AUDMUX port 6	AUD6	External – EIM or DISP2 through IOMUXC
AUDMUX port 7	SSI 3	Internal

NOTE

The terms WL and BL used in the timing diagrams and tables refer to Word Length (WL) and Bit Length (BL).

4.11.20.1 SSI Transmitter Timing with Internal Clock

Figure 96 depicts the SSI transmitter internal clock timing and Table 86 lists the timing parameters for the SSI transmitter internal clock.

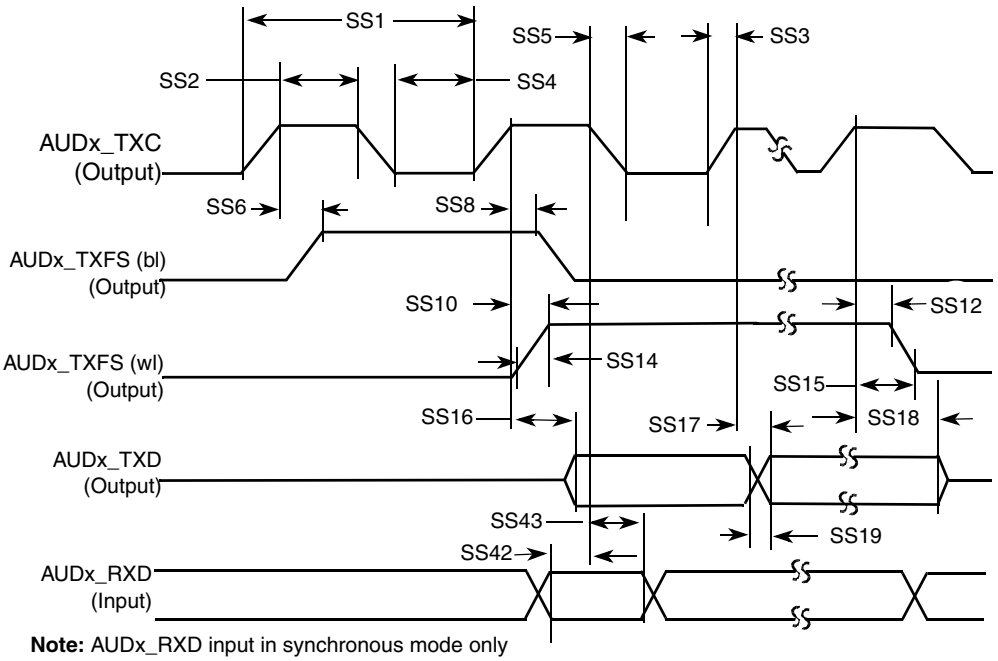

Figure 96. SSI Transmitter Internal Clock Timing Diagram

Table 97. Fuses and Associated Pins Used for Boot (continued)

Pin	Direction at Reset	eFuse Name
EIM_A18	Input	BOOT_CFG3[2]
EIM_A19	Input	BOOT_CFG3[3]
EIM_A20	Input	BOOT_CFG3[4]
EIM_A21	Input	BOOT_CFG3[5]
EIM_A22	Input	BOOT_CFG3[6]
EIM_A23	Input	BOOT_CFG3[7]
EIM_A24	Input	BOOT_CFG4[0]
EIM_WAIT	Input	BOOT_CFG4[1]
EIM_LBA	Input	BOOT_CFG4[2]
EIM_EB0	Input	BOOT_CFG4[3]
EIM_EB1	Input	BOOT_CFG4[4]
EIM_RW	Input	BOOT_CFG4[5]
EIM_EB2	Input	BOOT_CFG4[6]
EIM_EB3	Input	BOOT_CFG4[7]

1 Pin value overrides fuse settings for BT_FUSE_SEL = ‘0’. Signal Configuration as Fuse Override Input at Power Up. These are special I/O lines that control the boot up configuration during product development. In production, the boot configuration can be controlled by fuses.

5.2 Boot Devices Interfaces Allocation

Table 98 lists the interfaces that can be used by the boot process in accordance with the specific boot mode configuration. The table also describes the interface’s specific modes and IOMUXC allocation, which are configured during boot when appropriate.

Table 98. Interfaces Allocation During Boot

Interface	IP Instance	Allocated Pads During Boot	Comment
SPI	ECSPI-1	EIM_D17, EIM_D18, EIM_D16, EIM_EB2, EIM_D19, EIM_D24, EIM_D25	—
SPI	ECSPI-2	CSI0_DAT10, CSI0_DAT9, CSI0_DAT8, CSI0_DAT11, EIM_LBA, EIM_D24, EIM_D25	—
SPI	ECSPI-3	DISP0_DAT2, DISP0_DAT1, DISP0_DAT0, DISP0_DAT3, DISP0_DAT4, DISP0_DAT5, DISP0_DAT6	—
SPI	ECSPI-4	EIM_D22, EIM_D28, EIM_D21, EIM_D20, EIM_A25, EIM_D24, EIM_D25	—
SPI	ECSPI-5	SD1_DAT0, SD1_CMD, SD1_CLK, SD1_DAT1, SD1_DAT2, SD1_DAT3, SD2_DAT3	—
EIM	EIM	EIM_DA[15:0], EIM_D[31:16], CSI0_DAT[19:4], CSI0_DATA_EN, CSI0_VSYNC	Used for NOR, OneNAND boot Only CS0 is supported

NOTES:

1. ALL DIMENSIONS IN MILLIMETERS.
2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M–1994.
3. MAXIMUM SOLDER BALL DIAMETER MEASURED PARALLEL TO DATUM A.
4. DATUM A, THE SEATING PLANE, IS DETERMINED BY THE SPHERICAL CROWNS OF THE SOLDER BALLS.
5. PARALLELISM MEASUREMENT SHALL EXCLUDE ANY EFFECT OF MARK ON TOP SURFACE OF PACKAGE.
6. 21.2MM MAXIMUM PACKAGE ASSEMBLY (LID + LAMINATE) X AND Y.

	MECHANICAL OUTLINE	PRINT VERSION NOT TO SCALE
TITLE: 624 I/O FC PBGA, 21 X 21 X 2 PKG, 0.8 MM PITCH, STAMPED LID	DOCUMENT NO: 98ASA00330D	REV: D
	STANDARD: NON–JEDEC	
	08 OCT 2013	

Figure 107. 21 x 21 mm Lidded Package Top, Bottom, and Side Views (Sheet 2 of 2)

Table 100. 21 x 21 mm Functional Contact Assignments (continued)

Ball Name	Ball	Power Group	Ball Type	Out of Reset Condition[1]			
				Default Mode (Reset Mode)	Default Function (Signal Name)	Input/Output	Value[2]
DISP0_DAT18	V25	NVCC_LCD	GPIO	ALT5	GPIO5_IO12	Input	PU (100K)
DISP0_DAT19	U23	NVCC_LCD	GPIO	ALT5	GPIO5_IO13	Input	PU (100K)
DISP0_DAT2	P23	NVCC_LCD	GPIO	ALT5	GPIO4_IO23	Input	PU (100K)
DISP0_DAT20	U22	NVCC_LCD	GPIO	ALT5	GPIO5_IO14	Input	PU (100K)
DISP0_DAT21	T20	NVCC_LCD	GPIO	ALT5	GPIO5_IO15	Input	PU (100K)
DISP0_DAT22	V24	NVCC_LCD	GPIO	ALT5	GPIO5_IO16	Input	PU (100K)
DISP0_DAT23	W24	NVCC_LCD	GPIO	ALT5	GPIO5_IO17	Input	PU (100K)
DISP0_DAT3	P21	NVCC_LCD	GPIO	ALT5	GPIO4_IO24	Input	PU (100K)
DISP0_DAT4	P20	NVCC_LCD	GPIO	ALT5	GPIO4_IO25	Input	PU (100K)
DISP0_DAT5	R25	NVCC_LCD	GPIO	ALT5	GPIO4_IO26	Input	PU (100K)
DISP0_DAT6	R23	NVCC_LCD	GPIO	ALT5	GPIO4_IO27	Input	PU (100K)
DISP0_DAT7	R24	NVCC_LCD	GPIO	ALT5	GPIO4_IO28	Input	PU (100K)
DISP0_DAT8	R22	NVCC_LCD	GPIO	ALT5	GPIO4_IO29	Input	PU (100K)
DISP0_DAT9	T25	NVCC_LCD	GPIO	ALT5	GPIO4_IO30	Input	PU (100K)
DRAM_A0	AC14	NVCC_DRAM	DDR	ALT0	DRAM_ADDR00	Output	0
DRAM_A1	AB14	NVCC_DRAM	DDR	ALT0	DRAM_ADDR01	Output	0
DRAM_A10	AA15	NVCC_DRAM	DDR	ALT0	DRAM_ADDR10	Output	0
DRAM_A11	AC12	NVCC_DRAM	DDR	ALT0	DRAM_ADDR11	Output	0
DRAM_A12	AD12	NVCC_DRAM	DDR	ALT0	DRAM_ADDR12	Output	0
DRAM_A13	AC17	NVCC_DRAM	DDR	ALT0	DRAM_ADDR13	Output	0
DRAM_A14	AA12	NVCC_DRAM	DDR	ALT0	DRAM_ADDR14	Output	0
DRAM_A15	Y12	NVCC_DRAM	DDR	ALT0	DRAM_ADDR15	Output	0
DRAM_A2	AA14	NVCC_DRAM	DDR	ALT0	DRAM_ADDR02	Output	0
DRAM_A3	Y14	NVCC_DRAM	DDR	ALT0	DRAM_ADDR03	Output	0
DRAM_A4	W14	NVCC_DRAM	DDR	ALT0	DRAM_ADDR04	Output	0
DRAM_A5	AE13	NVCC_DRAM	DDR	ALT0	DRAM_ADDR05	Output	0
DRAM_A6	AC13	NVCC_DRAM	DDR	ALT0	DRAM_ADDR06	Output	0
DRAM_A7	Y13	NVCC_DRAM	DDR	ALT0	DRAM_ADDR07	Output	0
DRAM_A8	AB13	NVCC_DRAM	DDR	ALT0	DRAM_ADDR08	Output	0
DRAM_A9	AE12	NVCC_DRAM	DDR	ALT0	DRAM_ADDR09	Output	0
DRAM_CAS	AE16	NVCC_DRAM	DDR	ALT0	DRAM_CAS_B	Output	0
DRAM_CS0	Y16	NVCC_DRAM	DDR	ALT0	DRAM_CS0_B	Output	0
DRAM_CS1	AD17	NVCC_DRAM	DDR	ALT0	DRAM_CS1_B	Output	0
DRAM_D0	AD2	NVCC_DRAM	DDR	ALT0	DRAM_DATA00	Input	PU (100K)
DRAM_D1	AE2	NVCC_DRAM	DDR	ALT0	DRAM_DATA01	Input	PU (100K)
DRAM_D10	AA6	NVCC_DRAM	DDR	ALT0	DRAM_DATA10	Input	PU (100K)

Table 100. 21 x 21 mm Functional Contact Assignments (continued)

Ball Name	Ball	Power Group	Ball Type	Out of Reset Condition[1]			
				Default Mode (Reset Mode)	Default Function (Signal Name)	Input/Output	Value[2]
GPIO_8	R5	NVCC_GPIO	GPIO	ALT5	GPIO1_IO08	Input	PU (100K)
GPIO_9	T2	NVCC_GPIO	GPIO	ALT5	GPIO1_IO09	Input	PU (100K)
HDMI_CLKM	J5	HDMI_VPH	—	—	HDMI_TX_CLK_N	—	—
HDMI_CLKP	J6	HDMI_VPH	—	—	HDMI_TX_CLK_P	—	—
HDMI_D0M	K5	HDMI_VPH	—	—	HDMI_TX_DATA0_N	—	—
HDMI_D0P	K6	HDMI_VPH	—	—	HDMI_TX_DATA0_P	—	—
HDMI_D1M	J3	HDMI_VPH	—	—	HDMI_TX_DATA1_N	—	—
HDMI_D1P	J4	HDMI_VPH	—	—	HDMI_TX_DATA1_P	—	—
HDMI_D2M	K3	HDMI_VPH	—	—	HDMI_TX_DATA2_N	—	—
HDMI_D2P	K4	HDMI_VPH	—	—	HDMI_TX_DATA2_P	—	—
HDMI_HPD	K1	HDMI_VPH	—	—	HDMI_TX_HPD	—	—
JTAG_MOD	H6	NVCC_JTAG	GPIO	ALT0	JTAG_MODE	Input	PU (100K)
JTAG_TCK	H5	NVCC_JTAG	GPIO	ALT0	JTAG_TCK	Input	PU (47K)
JTAG_TDI	G5	NVCC_JTAG	GPIO	ALT0	JTAG_TDI	Input	PU (47K)
JTAG_TDO	G6	NVCC_JTAG	GPIO	ALT0	JTAG_TDO	Output	Keeper
JTAG_TMS	C3	NVCC_JTAG	GPIO	ALT0	JTAG_TMS	Input	PU (47K)
JTAG_TRSTB	C2	NVCC_JTAG	GPIO	ALT0	JTAG_TRST_B	Input	PU (47K)
KEY_COL0	W5	NVCC_GPIO	GPIO	ALT5	GPIO4_IO06	Input	PU (100K)
KEY_COL1	U7	NVCC_GPIO	GPIO	ALT5	GPIO4_IO08	Input	PU (100K)
KEY_COL2	W6	NVCC_GPIO	GPIO	ALT5	GPIO4_IO10	Input	PU (100K)
KEY_COL3	U5	NVCC_GPIO	GPIO	ALT5	GPIO4_IO12	Input	PU (100K)
KEY_COL4	T6	NVCC_GPIO	GPIO	ALT5	GPIO4_IO14	Input	PU (100K)
KEY_ROW0	V6	NVCC_GPIO	GPIO	ALT5	GPIO4_IO07	Input	PU (100K)
KEY_ROW1	U6	NVCC_GPIO	GPIO	ALT5	GPIO4_IO09	Input	PU (100K)
KEY_ROW2	W4	NVCC_GPIO	GPIO	ALT5	GPIO4_IO11	Input	PU (100K)
KEY_ROW3	T7	NVCC_GPIO	GPIO	ALT5	GPIO4_IO13	Input	PU (100K)
KEY_ROW4	V5	NVCC_GPIO	GPIO	ALT5	GPIO4_IO15	Input	PD (100K)
LVDS0_CLK_N	V4	NVCC_LVDS_2P5	LVDS	—	LVDS0_CLK_N	—	—
LVDS0_CLK_P	V3	NVCC_LVDS_2P5	LVDS	ALT0	LVDS0_CLK_P	Input	Keeper
LVDS0_TX0_N	U2	NVCC_LVDS_2P5	LVDS	—	LVDS0_TX0_N	—	—
LVDS0_TX0_P	U1	NVCC_LVDS_2P5	LVDS	ALT0	LVDS0_TX0_P	Input	Keeper
LVDS0_TX1_N	U4	NVCC_LVDS_2P5	LVDS	—	LVDS0_TX1_N	—	—
LVDS0_TX1_P	U3	NVCC_LVDS_2P5	LVDS	ALT0	LVDS0_TX1_P	Input	Keeper
LVDS0_TX2_N	V2	NVCC_LVDS_2P5	LVDS	—	LVDS0_TX2_N	—	—
LVDS0_TX2_P	V1	NVCC_LVDS_2P5	LVDS	ALT0	LVDS0_TX2_P	Input	Keeper
LVDS0_TX3_N	W2	NVCC_LVDS_2P5	LVDS	—	LVDS0_TX3_N	—	—

7 Revision History

Table 103 provides a revision history for this data sheet.

Table 103. i.MX 6Dual/6Quad Data Sheet Document Revision History

Rev. Number	Date	Substantive Change(s)
4	07/2015	• Added footnote to Table 1, "Example Orderable Part Numbers," on page 3: If a 24 MHz input clock is used (required for USB), the maximum SoC speed is limited to 996 MHz. • Section 1.2, “Features” changed Five UARTs, from *up to 4.0 Mbps*, to *up to 5.0 Mbps.* • Table 6, "Operating Ranges," on page 21: Row: VDD_HIGH internal regulator, changed minimum parameter value from 2.8 to 2.7V. • Table 6, "Operating Ranges," on page 21: Removed footnote: *VDDSOC and VDDPU output voltages must be set according to this rule: VDDARM-VDDSOC/PU<50mV.* This was a duplicate footnote, renumbered footnotes accordingly. • Table 6, "Operating Ranges," on page 21: Changed value: *Standby/DSM Mode, VDD_SOC_IN, minimum voltage, from 0.9V to 1.05V.* • Table 8, "Maximum Supply Currents," on page 25, Differentiated VDD_ARM_IN, VDD_ARM23_IN, and VDD_SOC_IN by frequency and by Power Virus/CoreMark maximum current. • Table 21, "XTALI and RTC_XTALI DC Parameters," on page 38, Added rows: *Input capacitance*; *Startup current*; and *DC input current* and their values. • Table 40, "EIM Bus Timing Parameters," on page 53, Changed WE4–WE17 minimum and maximum parameter values from, *0.5 t (k+1)/2-1.25*, to *0.5 x t x (k+1)-1.25.* • Table 41, "EIM Asynchronous Timing Parameters Relative to Chip Select^{1}," on page 60 Added to end of formulas in the minimum, typical, and maximum parameter values for WE31–WE42 and WE45–WE46, $\times t$. For example from *3-CSN*, to *3-CSN*$\times t$. Also added maximum value to MAXDTI of 10. • Table 43, "DDR3/DDR3L Write Cycle," on page 63, Changed minimum parameter value of DDR17 from 240 to 125; and of DDR18 from 240 to 150. • Figure 27, "LPDDR2 Command and Address Timing Diagram," on page 64, LP2 signal cycle reduced. • Table 46, "LPDDR2 Write Cycle," on page 65, Changed LP21 minimum and maximum parameter value from -0.25/+0.25 to 0.8/1.2. • Figure 41, "ECSPI Master Mode Timing Diagram," on page 76, Added footnote: *Note: ECSPIx_MOSI is always driven (not tri-stated) between actual data transmissions. This limits the ECSPI to be connected between a single master and a single slave.* • Figure 42, "ECSPI Slave Mode Timing Diagram," on page 77, Added footnote: *Note: ECSPIx_MISO is always driven (not tri-stated) between actual data transmissions. This limits the ECSPI to be connected between a single master and a single slave.* • Figure 65, "Gated Clock Mode Timing Diagram," on page 98, Corrected IPU2_CSIx_HSYNC trace drawing. • Section 4.11.23, “USB PHY Parameters” Specified *Battery Charging Specification* applies to portable devices only.

Table 103. i.MX 6Dual/6Quad Data Sheet Document Revision History (continued)

Rev. Number	Date	Substantive Change(s)
Rev. 2	04/2013	Substantive changes throughout this document are as follows: • Incorporated standardized signal names. This change is extensive throughout. Added reference to EB792, i.MX Signal Name Mapping. • Figures updated to align to standardized signal names. • Aligned references to FCBGA to read FC**P**BGA throughout document. • Updated references to eMMC standard to include 4.41. • Table 2, "i.MX 6Dual/6Quad Modules List," Changed reference to Global Power Controller to read General Power Controller. • Table 4, "Absolute Maximum Ratings," Added VDD_ARM23_IN to Core supply voltages. • Table 6 "Operating Ranges ": Run Mode - LDO Enabled, VDD_ARM_IN/VDD_ARM23_IN, 792 MHz, input voltage minimum changed to 1.275V and VDD_ARM CAP minimum changed to 1.150V. NVCC_NAND, changed to NVCC_NANDF. • Table 6 "Operating Ranges ": Added reference for information on product lifetime : *i.MX 6Dual/6Quad Product Usage Lifetime Estimates Application Note*, AN4724. • Table 9. "Maximum Supply Currents": Added current for i.MX6Dual • Table 10 "Stop Mode Current and Power Consumption": Added SNVS Only mode. • Table 22 "GPIO I/O DC Parameters": Removed parameters Iskod and Isspp. • Table 48, "ECSPI Master Mode Timing Parameters," Updated parameter CS6 ECSPIx_SSx Lag Time (CS hold time) Min from Half SCLK period to Half SCLK period-2. • Table 77 "SD/eMMC4.3 Interface Timing Specification," eMMC parameter SD8 value Min updated from 5.6 ns to 1.5 ns. • Table 89 RGMII Signal Switching Specifications RGMII parameter TskewR units corrected. • Table 134 "21 x 21 mm Functional Contact Assignments," Updated GPIO_1 Ball Name value to PU (100K). • Table 134 "21 x 21 mm Functional Contact Assignments," Clarification of ENET_REF_CLK naming. • Removed section, EIM Signal Cross Reference. Signal names are now aligned with reference manual. • Section 1.2, "Features added bulleted item regarding the SOC-level memory system. • Section 4.2.1, "Power-Up Sequence" updated wording. • Section 4.3.2, "Regulators for Analog Modules" section updates. • Added Section 4.6.1, "XTALI and RTC_XTALI (Clock Inputs) DC Parameters". • Section 4.10, "General-Purpose Media Interface (GPMI) Timing" figures replaced, tables revised.